Application/Control No. O9/975,540 Examiner Alexander Markoff Applicant(s)/Patent Under Reexamination CHANG ET AL. Art Unit Page 1 of 1

Notice of References Cited

U.S. PATENT DOCUMENTS

*		Docúment Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification .
	Α	US-5,235,995	08-1993	Bergman et al.	134/105
	В	US-5,282,925	02-1994	Jeng et al.	216/59
	С	US-5,770,263	06-1998	Hawthorne et al.	427/309
	D .	US-5,972,161	10-1999	Kim et al.	156/345.31
	Ε	US-6,073,636	06-2000	Kim et al.	134/1.3
	F	US-6,323,463	11-2001	Davis et al.	219/390
	G	US-6,358,859	03-2002	Lo et al.	438/712
	Η	US-6,410,889	06-2002	Davis et al.	219/390
	I	US-		,	
	J	US-			
	К	US-			
	L	US-		·	
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	GB 2313574 A	12-1997	United Kingdom	KIM et al.	H01J 37/32
	0					
	Р	·				
	Q					·
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.